Record Nr. UNINA9910830751403321 Advanced dielectric, piezoelectric and ferroelectric thin films **Titolo** [[electronic resource]]: proceedings of the 106th Annual Meeting of the American Ceramic Society, Indianapolis, Indiana, USA (2004) // editors, Bruce A. Tuttle ... [et al.] Westerville, Ohio, : American Ceramic Society, c2005 Pubbl/distr/stampa **ISBN** 1-280-67391-5 9786613650849 1-118-40720-2 1-118-40722-9 Descrizione fisica 1 online resource (98 p.) Collana Ceramic transactions;; v. 162 Altri autori (Persone) **TuttleBruce** Disciplina 621.3815/2 621.38152 Thin films - Materials Soggetti Thin film devices Lingua di pubblicazione Inglese **Formato** Materiale a stampa Livello bibliografico Monografia Note generali "... selected papers from the Advanced Dielectric, Piezoelectric and Ferroelectric Thin Films Symposium held at the American Ceramic Society's 106th Annual Meeting, April 18-21, 2004 in Indianapolis. Indiana."--p. vii. Includes bibliographical references and indexes. Nota di bibliografia Nota di contenuto Advanced Dielectric, Piezoelectric and Ferroelectric Thin Films; Contents; Preface; Chemical Solution Deposition of CaCu3Ti4O12 Thin Films: The Temporal Effects in DC-Biased PbNb(Zr,Sn,Ti)O3: High Energy Density PLZT Thin Film Capacitors; Reliability Studies on Sputter Deposited Barium Strontium Titanate Thin Film Capacitors; Raman Study of Effects of Excess Bi Content in Metalorganic Derived Bi4Ti3O12 Films; High Dielectric Tunability Ferroelectric (Pb,Sr)TiO3 Thin Films for Room Temperature Tunable Microwave Devices; Fabrication of Self-Assembled Nanostrutures of Microwave Dielectrics Epitaxial Phase Selection in the Rare Earth Manganite SystemMulti-Ferroic BiFeO3 Films Prepared by Liquid Phase Epitaxy and Sol-Gel Methods; Effect of Argon Addition During ECR Mode Nucleation of Diamond Films Grown by MPCVD; Author Index; Keyword Index

Sommario/riassunto

Advances in synthesis and characterization of dielectric, piezoelectric and ferroelectric thin films are included in this volume. Dielectric, piezoelectric and ferroelectric thin films have a tremendous impact on a variety of commercial and military systems including tunable microwave devices, memories, MEMS devices, actuators and sensors. Recent work on piezoelectric characterization, AFE to FE dielectric phase transformation dielectrics, solution and vapor deposited thin films, and materials integration are among the topics included. Novel approaches to nanostructuring, characterization of m